

<b>Notice of References Cited</b>	Application/Control No. 10/669,289	Applicant(s)/Patent Under Reexamination MORINO, TAKASHI	
	Examiner Yubin Hung	Art Unit 2624	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0028049	02-2004	Wan, Ernest Yiu Cheong	370/394
*	B	US-5,038,392	08-1991	Morris et al.	382/175
*	C	US-6,320,521	11-2001	Har et al.	341/50
*	D	US-2003/0043852	03-2003	Tadayon et al.	370/477
*	E	US-6,728,466	04-2004	Tanaka, Hirsoshi	386/46
*	F	US-5,764,286	06-1998	Kawamura et al.	348/231.6
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Marvel et al. ("Compression-Compatible Fragile and Semi-Fragile Tamper Detection," Proceedings of SPIE, Vol. 3971, 2000, pp. 131-139)
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.